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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)	<i>Complete if Known</i>	
	Application Number	10/673,756
	Filing Date	September 29, 2003
	First Named Inventor	Marotta, Giulio-Giuseppe
	Group Art Unit	2819
	Examiner Name	Le, Don
Sheet 1 of 1	Attorney Docket No: 303.698US2	

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Examiner Initial *	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Filing Date If Appropriate
<i>LS</i>	US-6,282,145	08/28/2001	Tran, Hieu V., et al.	01/14/1999

EXAMINER

Don Le

DATE CONSIDERED

3/25/05

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Complete if Known

Application Number: Unknown 10673756
 Filing Date: Even Date Herewith
 First Named Inventor: Marotta, Giulio-Giuseppe
 Group Art Unit: 0 2819
 Examiner Name: Unknown

Sheet 1 of 2

Attorney Docket No: 303.698US2

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5/4/04

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Complete if Known

Application Number	Unknown	10673756
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First Named Inventor	Marotta, Giulio-Giuseppe	
Group Art Unit	0	2819
Examiner Name	Unknown	

Sheet 2 of 2

Attorney Docket No: 303.698US2

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